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Application/Control No.	Applicant(s)/Patent ι Reexamination	ınder
10/007,047	ROSS ET AL.	•
Examiner	Art Unit	
Brandon J. Fetterolf, PhD	1642	

SEARCHED			
Class	Subclass	Date	Examiner
435	6	5/8/2007	BF
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
WEST (see attached)	5/8/2007	BF
STN (reviewed)	5/8/2007	BF
STIC sequence search (SCORE) -SEQ ID NO: 1 na vs na -SEQ ID NO: 1 na oligo -reviewed	5/8/2007	BF
Inventor Search	5/8/2007	BF
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